

FMP12N60ES

FUJI POWER MOSFET

Super FAP-E^{3S} series

N-CHANNEL SILICON POWER MOSFET

Features

Maintains both low power loss and low noise Lower R_{DS}(on) characteristic More controllable switching dv/dt by gate resistance Smaller V_{GS} ringing waveform during switching Narrow band of the gate threshold voltage (4.2±0.5V)

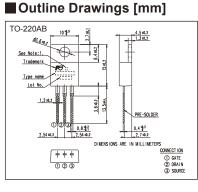
High avalanche durability

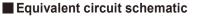
Applications

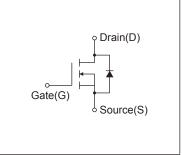
Switching regulators UPS (Uninterruptible Power Supply) **DC-DC converters**

Maximum Ratings and Characteristics

• Absolute Maximum Ratings at Tc=25°C (unless otherwise specified)







Description	Symbol	Characteristics	Unit	Remarks
Drain Source Voltage	VDS	600	V	
Drain-Source Voltage	VDSX	600	V	V _{GS} = -30V
Continuous Drain Current	lo	±12	А	
Pulsed Drain Current	DP	±48	А	
Gate-Source Voltage	Vgs	±30	V	
Repetitive and Non-Repetitive Maximum Avalanche Current	lar	12	А	Note*1
Non-Repetitive Maximum Avalanche Energy	Eas	384	mJ	Note*2
Repetitive Maximum Avalanche Energy	Ear	18	mJ	Note*3
Peak Diode Recovery dV/dt	dV/dt	4.4	kV/µs	Note*4
Peak Diode Recovery -di/dt	-di/dt	100	A/µs	Note*5
Maulinum Davida Dia dia dia d	PD	2.02	14/	Ta=25°C
Maximum Power Dissipation		180	W	Tc=25°C
	Tch	150	°C	
Operating and Storage Temperature range	Tstg	-55 to +150	°C	

• Electrical Characteristics at Tc=25°C (unless otherwise specified)

Description	Symbol	Conditions		min.	typ.	max.	Unit	
Drain-Source Breakdown Voltage	BVDSS	I _D =250µA, V _{GS} =0V	I _D =250µA, V _{GS} =0V		-	-	V	
Gate Threshold Voltage	V _{GS} (th)	ID=250µA, VDS=VGS	ID=250µA, VDS=VGS		4.2	4.7	V	
Zero Gate Voltage Drain Current		V _{DS} =600V, V _{GS} =0V	T _{ch} =25°C	-	-	25		
	IDSS	V _{DS} =480V, V _{GS} =0V	Tch=125°C	-	-	250	- μΑ	
Gate-Source Leakage Current	Igss	V _{GS} =±30V, V _{DS} =0V	V _{GS} =±30V, V _{DS} =0V		10	100	nA	
Drain-Source On-State Resistance	RDS (on)	I _D =6A, V _{GS} =10V		-	0.641	0.75	Ω	
Forward Transconductance	g fs	ID=6A, VDS=25V	ID=6A, VDS=25V		8	-	S	
Input Capacitance	Ciss	Vos=25V Vos=0V f=1MHz		-	1300	1950	pF	
Output Capacitance	Coss			-	150	225		
Reverse Transfer Capacitance	Crss			-	8.5	13		
Turn-On Time	td(on)	V _{cc} =300V V _{cs} =10V I _D =6A R _c =27Ω		-	40	60	ns	
	tr			-	40	60		
Turn-Off Time	td(off)			-	74	111		
	tf			-	19	29		
Total Gate Charge	QG			-	37	56		
Gate-Source Charge	QGS	V _{cc} =300V		-	15	23	1 -0	
Gate-Drain Charge	QGD	ID=12A VGS=10V		-	12	18	nC	
Gate-Drain Crossover Charge	Qsw			-	6.5	10		
Avalanche Capability	lav	L=2.64mH, Tch=25°C		11	-	-	A	
Diode Forward On-Voltage	Vsd	IF=11A, VGS=0V, Tch=25°C		-	0.86	1.30	V	
Reverse Recovery Time	trr	I _F =11A, V _{GS} =0V		-	0.52	-	μS	
Reverse Recovery Charge	Qrr	-di/dt=100A/µs, Tch=25°C		-	5.5	-	μC	

Thermal Characteristics

Description	Symbol	Test Conditions	min.	typ.	max.	Unit
Thermal resistance	Rth (ch-c)	Channel to case			0.690	°C/W
	Rth (ch-a)	Channel to ambient			62.0	°C/W

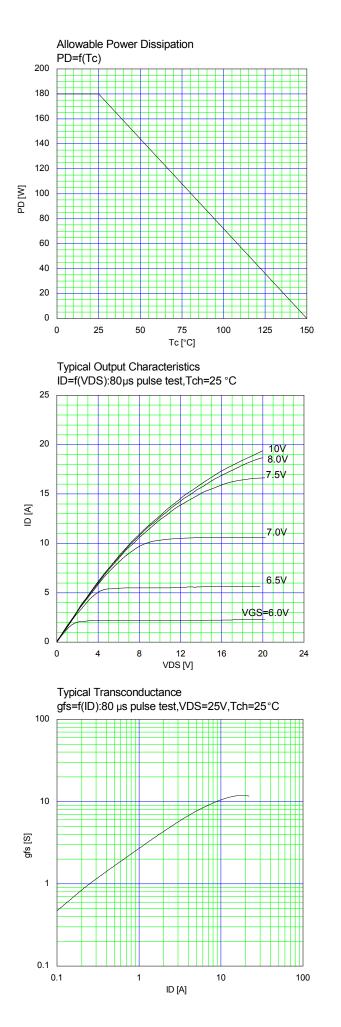
Note *1 : Tch≤150°C

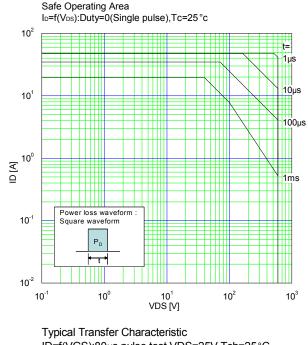
Note 1 : Italia 50 C, IAs=5A, L=28.2mH, Vcc=60V, R_G=50Ω EAs limited by maximum channel temperature and avalanche current. See to 'Avalanche Energy' graph.

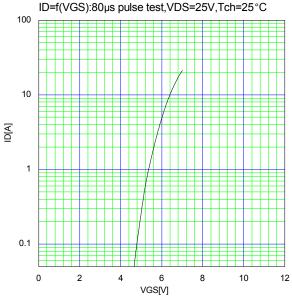
Note *3 : Repetitive rating : Pulse width limited by maximum channel temperature

See to the 'Transient Themal impeadance' graph.

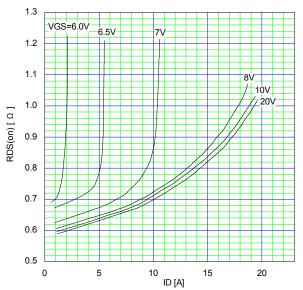
Note *4 : Ir<-ID, -di/dt=100A/µs, Vcc≤BVDss, Tch≤150°C. Note *5 : Ir<-ID, dv/dt=4.4kV/µs, Vcc≤BVDss, Tch≤150°C.







Typical Drain-Source on-state Resistance RDS(on)=f(ID):80 μs pulse test,Tch=25 $^\circ C$



0.1

0.00

0.25

0.50

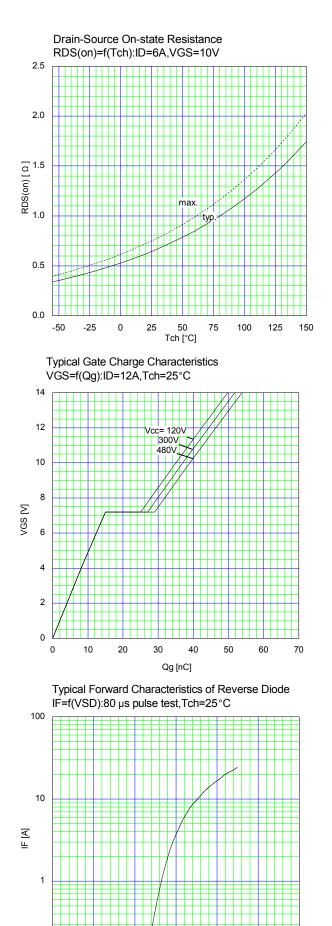
0.75

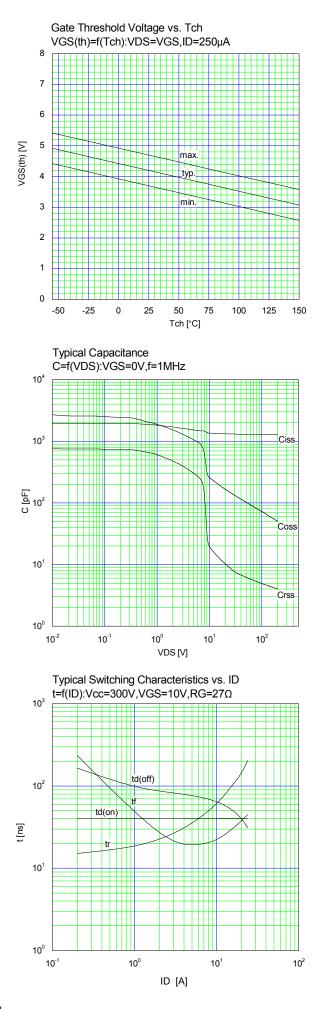
VSD [V]

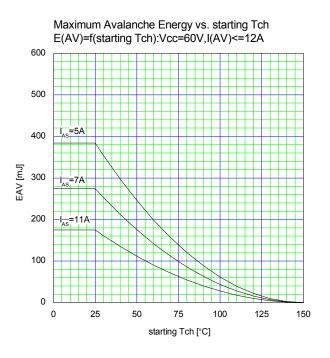
1.00

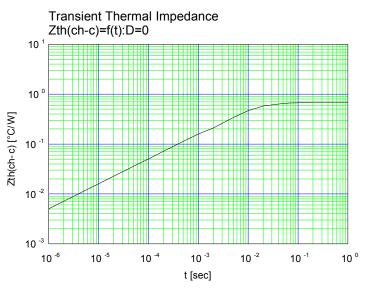
1.25

1.50









WARNING

		WARNING		
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